IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Patent Application Serial No	
Filing Date	September 5, 2003
Inventor	Jon P. Daley
Assignee	Micron Technology, Inc.
Group Art Unit	0 ,
Examiner	Pamela E. Perkins
Attorney's Docket No	MI22-2380
Customer No	021567
Title: Methods of Forming Patterned Photoresis	st Layers Over Semiconductor
Substrates	

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

References - See Attached Form PTO-1449

The attached form PTO-1449 is submitted in compliance with 37 CFR §1.56. No copies of any cited U.S. patents or U.S. published applications are included herewith. Copies of all other cited art are attached. No admission is made regarding whether all the submitted references are prior art.

Citation of these references is respectfully requested.

A check in the amount of \$180.00 is enclosed to cover the fee specified under 37 C.F.R. § 1.17(p).

Respectfully submitted,

Dated: 3-16-06

Mark 8 Matkin Reg. No. 32,268

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	AA	6,838,363	01/05	Wieczorek et al.						
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Ratent Application Serial No	10/655.997
Filing Date	September 5, 2003
Inventor	Jon P. Dalev
Assignee	Micron Technology, Inc.
Group Art Unit	
Examiner	Pamela E. Perkins
Attorney's Docket No	
Customer No	021567
Title: Methods of Forming Patterned Pho	otoresist Layers Over Semiconductor

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

References - See Attached Form PTO-1449

In compliance with 37 C.F.R. §§ 1.56, 1.97 and 1.98, your attention is directed to the United States patents and other references listed on the attached Form PTO-1449. No admission is made regarding whether all the submitted references are prior art.

This Supplemental Information Disclosure Statement is being filed before the mailing of a first office action after the filing of a Request for Continued Examination. Therefore, no fee is believed to be required. However, in the event that a fee is required for filing this Supplemental Information Disclosure Statement, please charge the fee specified under 37 C.F.R. § 1.17(p) to Deposit Account No. 23-0925.

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Respectfully submitted,

Dated: /2 - /-05

Mark S. Matkin Reg. No. 32,268

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ATTY. DOCKET NO. MI22-2380

SERIAL NO. 10/655,997

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LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)

APPLICANT: Jon P. Daley

FILING DATE September 5, 2003 GROUP ART UNIT 2822

Examiner's Initials		Document Number	Date	Name	Class	Subclass	Filing If Appro	Date opriate
	AA	3,772,101	11/1973	Chumbres et al.				
	AB	5,677,102	10/1997	Shihara				
	AC	6,096,634	08/2000	Nguyen				
	AD	6,165,834	12/2000	Agarwal et al.				
	AE	6,188,097	02/2001	Derderian et al.			-	•
	AF	6,238,994	05/2001	Derderian et al.				
	AG	6,255,035	07/2001	Minter et al.				
	AH	6,297,527	10/2001	Agarwal et al.				
	AI	6,376,149	04/2002	Grober et al.				•
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SERIAL NO. 10/655,997

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APPLICANT: Jon P. Daley

FILING DATE September 5, 2003

GROUP ART UNIT 2822

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*Examiner's Initials		Document Number	Date	Name	Class	Subclass	Filing If Appro	Date priate
	AA	6,399,982	06/2002	Derderian et al.				
	AB	6,511,896	01/2003	Basceri et al.				
	AC	6,608,343	08/2003	Derderian et al.				
	AD	6,617,250	09/2003	Basceri et al.				_
	AE	6,649,466	11/2003	Basceri et al.				
	AF	6,744,093	06/2004	Agarwal et al.				
	AG	6,746,916	06/2004	Agarwal et al.				
	АН	6,777,739	08/2004	Agarwal et al.				
	Al	6,780,766	08/2004	Basceri et al.				
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APPLICANT: Jon P. Daley

FILING DATE September 5, 2003 GROUP ART UNIT 2822

U.S. PATENT DOCUMENTS

Examiner's Initials		Document Number	Date	Name	Class	Subclass	Filing If Appro	Date priate
	AA	6,817,086	11/2004	Lu et al.				
	AB	6,900,497	05/2005	Agarwal et al.				
	AC							
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